

FIG. 1a

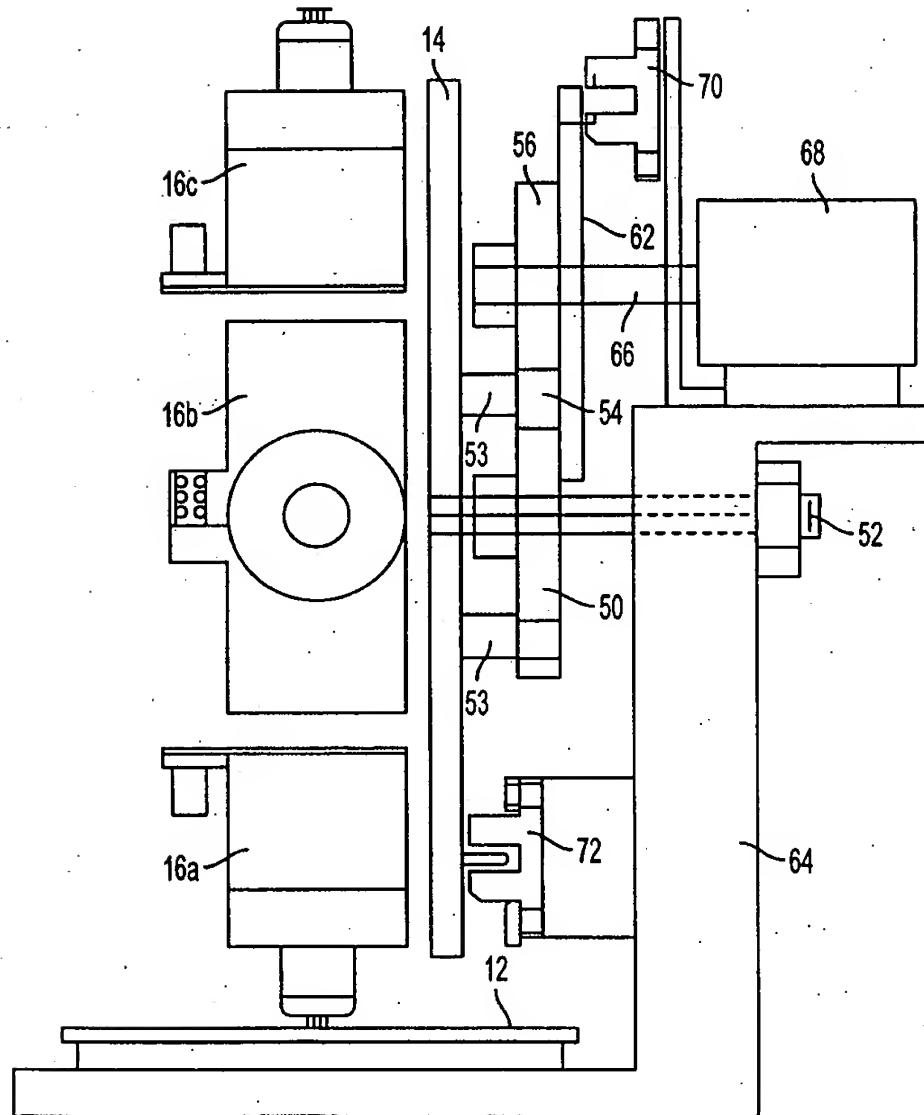


FIG. 1b

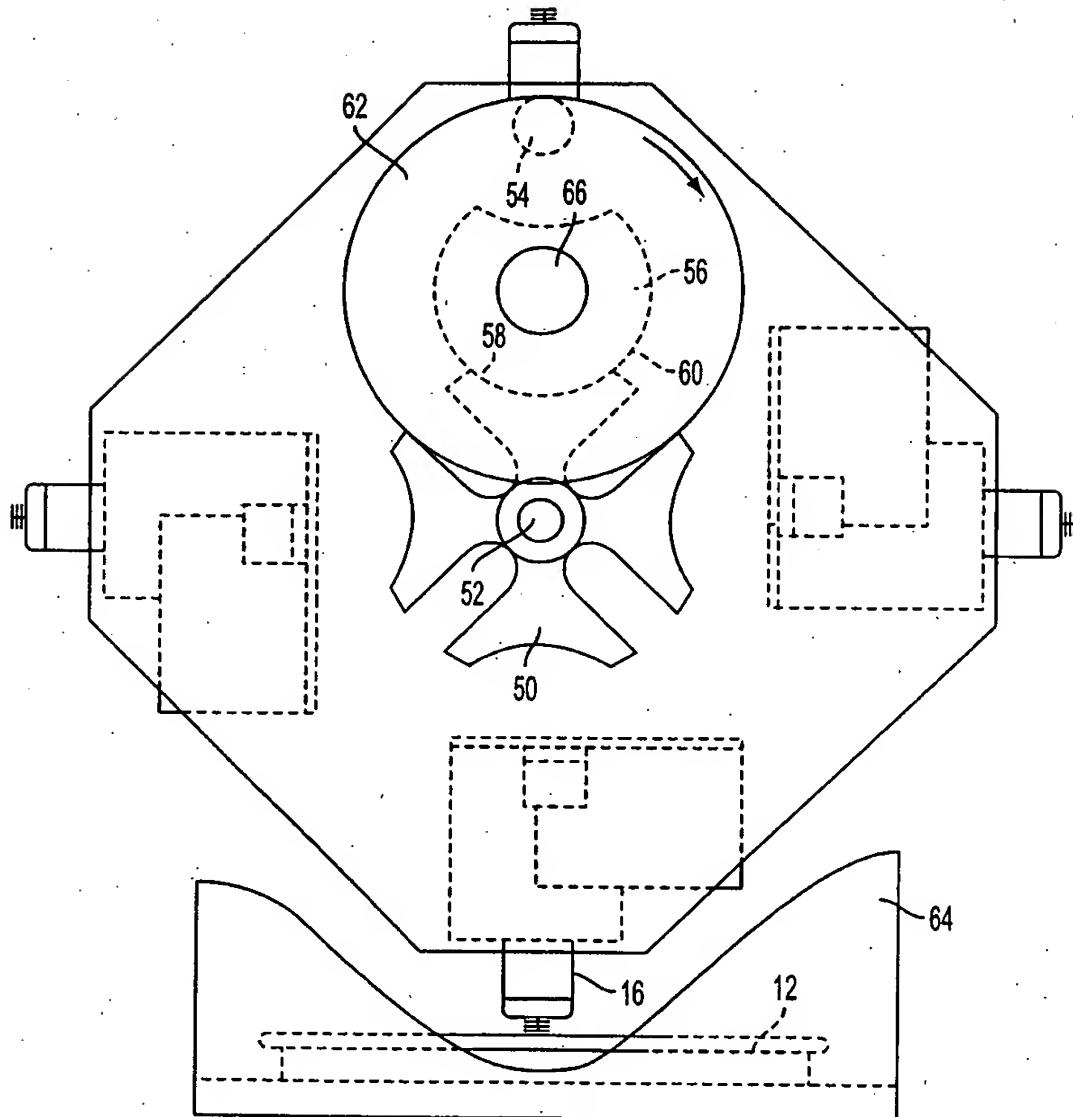
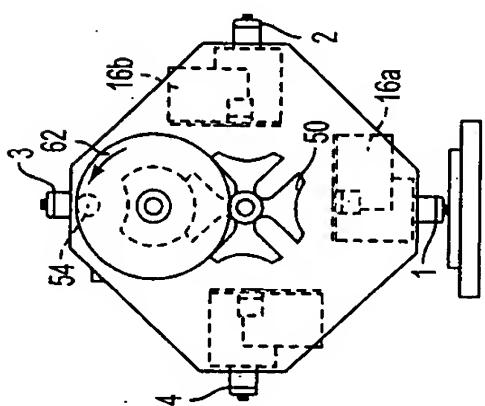
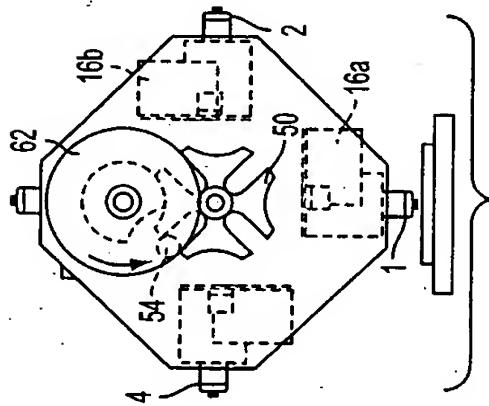
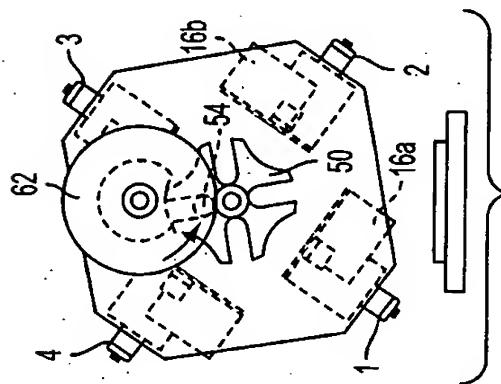
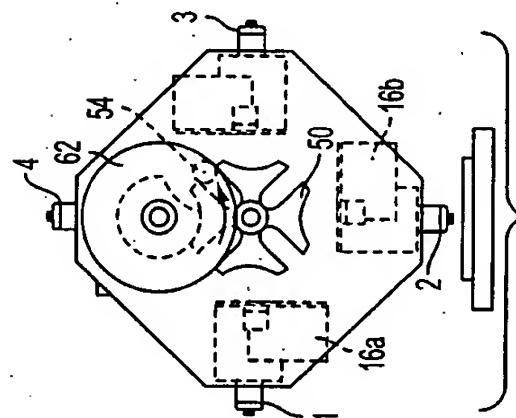


FIG. 2



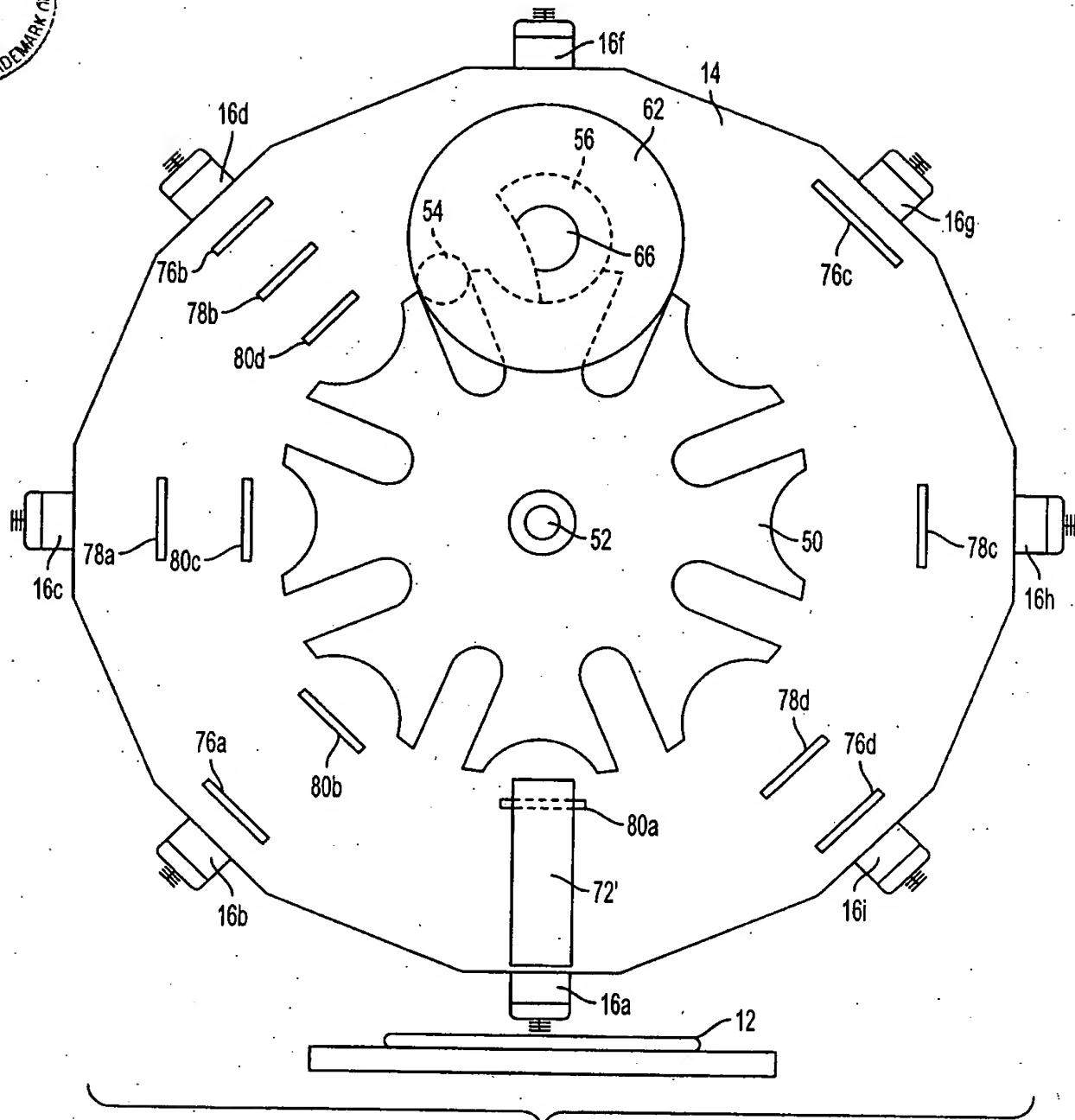


FIG. 4a

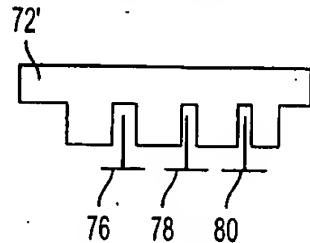


FIG. 4b



Title: "INDEXING MULTIPLE TEST PROBE SYSTEM AND METHOD" Inventor: David Cheng  
Attch. Docket No.: 59083-8011.US01 (6 of 8 Sheets)  
Serial No.: 10/066,394

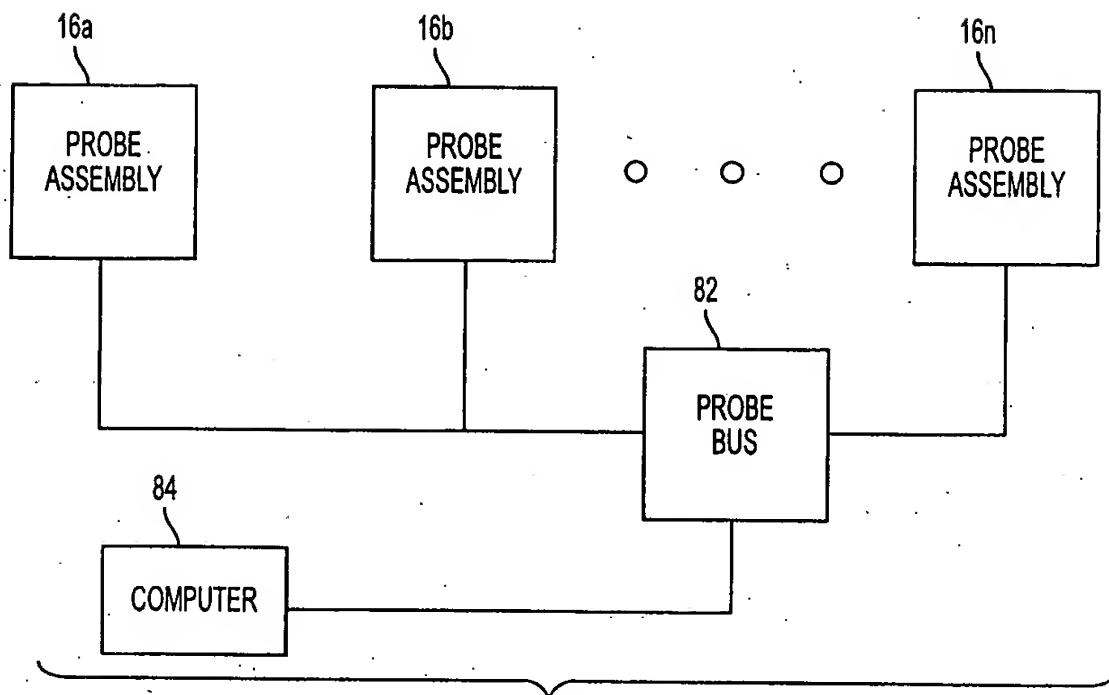


FIG. 5a

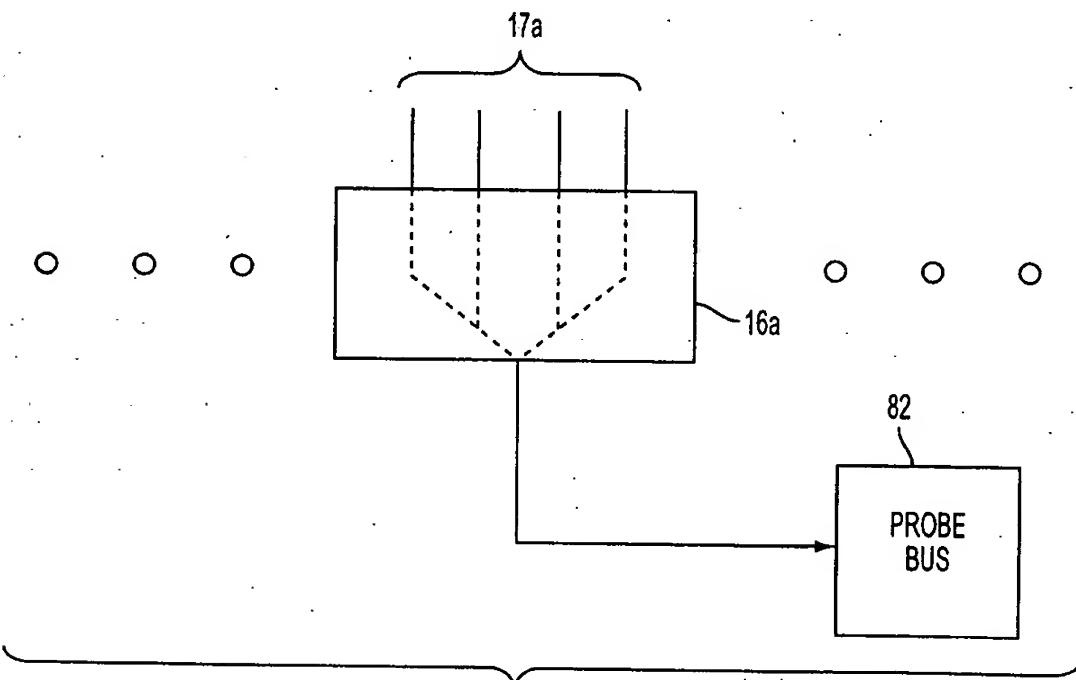
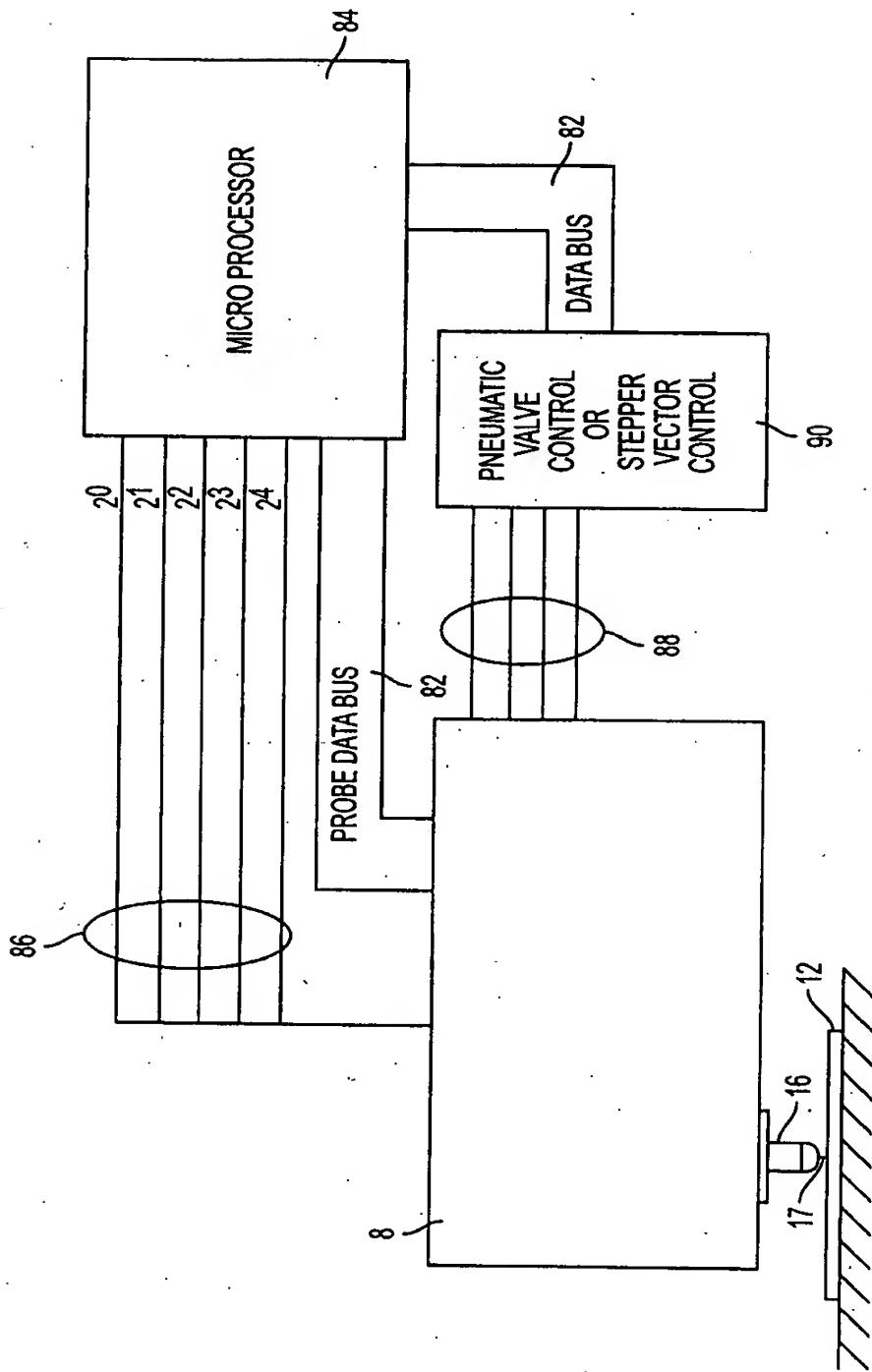


FIG. 5b



Title: "INDEXING MULTIPLE TEST PROBE SYSTEM,  
METHOD" Inventor: David Cheng  
Attorney Docket No.: 59083-8011.US01 (7 of 8 Sheets)  
Serial No.: 10/066,394



6  
**FIG**

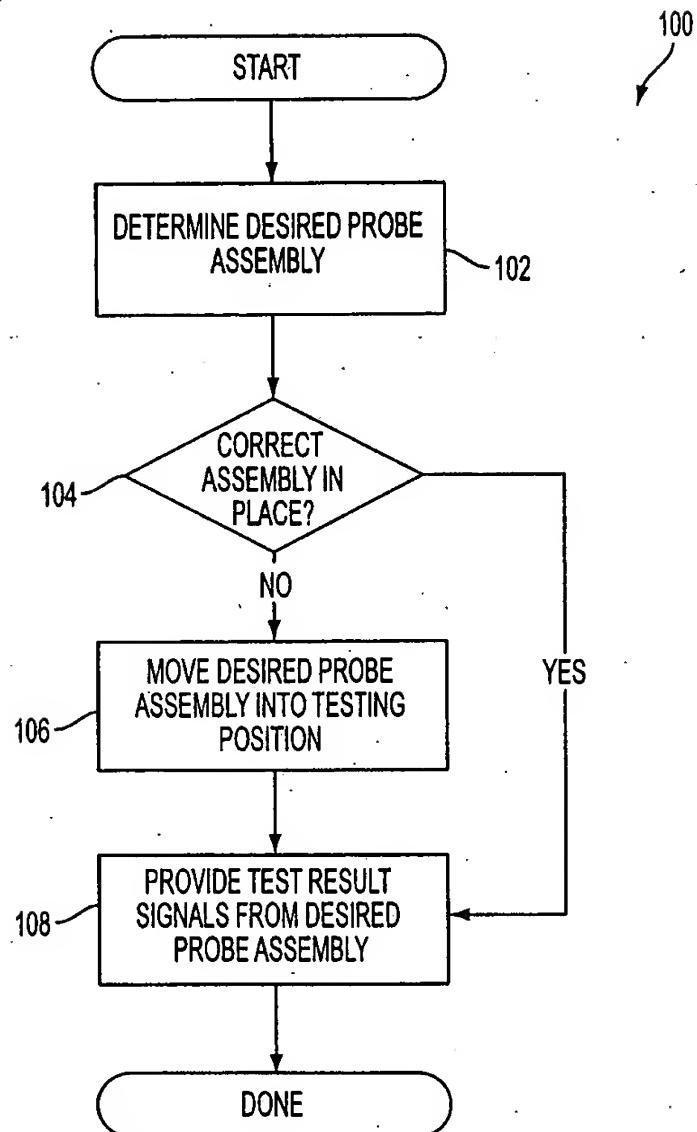


FIG. 7